

# DSS-CV21

## Environment Test Report

Report NO: 121P020006

Summary	<p><input type="checkbox"/> Pass</p> <p><input type="checkbox"/> Fail</p> <p>Note : There is/are ____ defect(s) not list in the report, please check it in the DTS Website.</p> <p><input checked="" type="checkbox"/> Pass with Deviation</p> <p><b>Comment: <u>Temperature points are two components were estimated to be in marginal temperature points in comparison with components datasheet.</u></b></p>
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Issue date

2012-12-13

Approval

Tom Lin

Test Engineer

Matthew Chi

## Test item list

1. <i>Test item list</i> -----	2
2. <i>Configuration of EUT</i> -----	3
2. <i>Temperature rise test</i> -----	4
3. <i>Temperature cycle operation test</i> -----	8
4. <i>High temperature storage test</i> -----	9
5. <i>Low temperature storage test</i> -----	10
6. <i>Humidity test</i> -----	11
7. <i>Cold start and hot start test</i> -----	12

### Testing Result

Num	Test item list	Result	Remark
1	Temperature rise test	Pass	
2	Temperature cycle operation test	Pass	
3	High temperature storage test	Pass	
4	Low temperature storage test	Pass	
5	Humidity test	Pass	
6	Cold start and hot start test	Pass	

# Configuration of EUT

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Item	Device Information	
SYSTEM PC Model / Ver.	DSS-CV21 A1.0	
CPU Board	ASUS E81030 Rev 1.01	
BIOS / Version	0401	
CPU Type	Intel Atom D2550 1.86GHz	
Memory Type	DSL DDR3 1066 2GB ELPIDA J1108BDSE-DJ-E x2	
HDD	WD WD160BEVT 2.5" 160GB	
Operating System	<input checked="" type="checkbox"/>	Windows 7 Professional English 32 Bit
DC Adapter	ASUS ADP-90CD/ DC 19V/ 4.74A	

## System picture:



# Temperature rise test

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**Test Date:** 12-13-2012

**Test Product:** DSS-CV21

**Test Site:** AAEON QE Dept.

**Test Standard:** Reference EN 61131-2(94), UL508 (94)

**Temperature Measurement:**

40 Channel Thermal Recorder:

YOKOGAWA Inc,

Model: DA100-13-1D

Date of Calibration: 10/12/2011

Serial Number: 12A323190

**Test Condition:**

Ambient temperature: 45°C

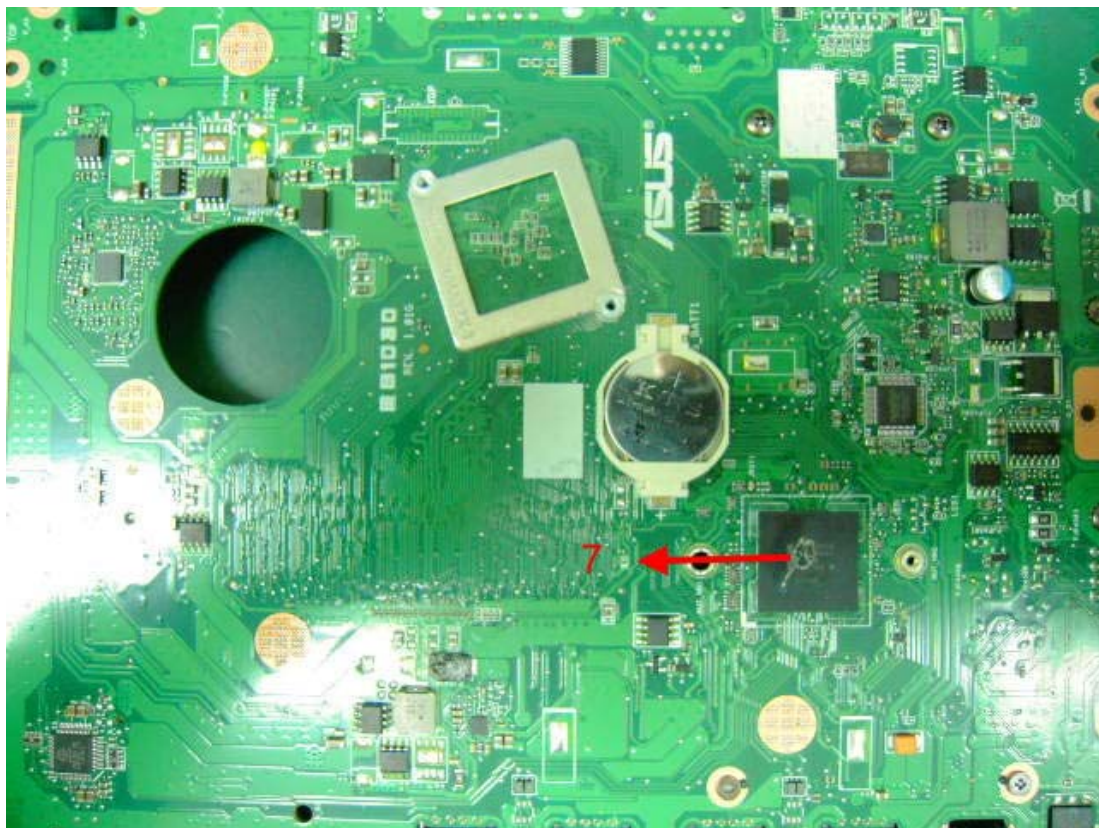
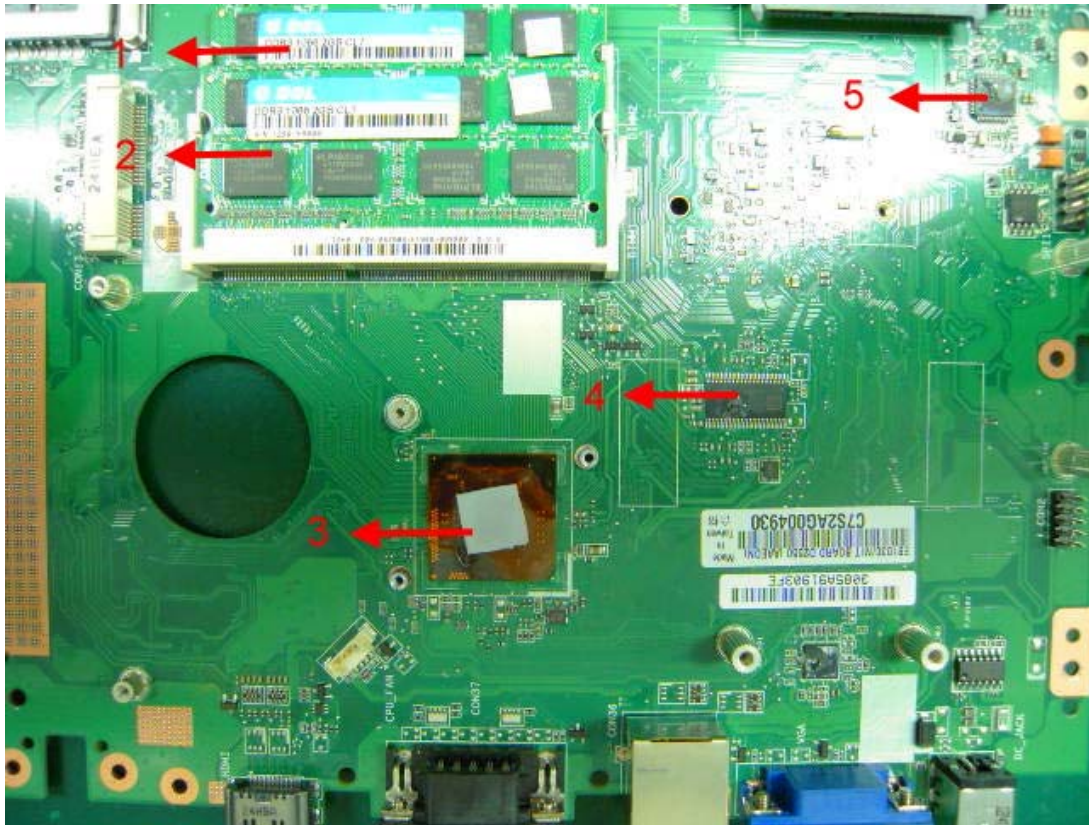
Continuous running till thermal stable (within less than 1°C)

**Test Software:**

Windows 7 / Run PassMark Burn In Test 7.0 Pro

**Terminal Recorder:**

# Temperature rise test



# Temperature rise test



# Temperature rise test

## Thermal profile data:

Point	Temp. Stage(°C)	Spec	45	Note
01. Memory 1 - DSL DDR3 1066 2GB ELPIDA J1108BDSE-DJ-E		95	93.7	Note4
02. Memory 2 - DSL DDR3 1066 2GB ELPIDA J1108BDSE-DJ-E		95	92.5	Note4
03. CU1 - Intel Atom D2550 1.86GHz		100	79.1	
04. CGU – Clock Gen. 9LPRS432		115	88.6	
05. AU1 - (TF) Audio Codec. output.SMD.Realtek.ALC887-VD2-CG		100.5	79.8	
06. HDD - WD WD160BEVT 2.5” 160GB		85	71.3	
07. C.S CG82NM10 903500 INT TIGERPOINT NM10 SLGXX [HF].SMD		115	92.5	
08. Control Box Inside Air Temperature		N/A	60.6	
09. Control Box Surface Temperature		N/A	59.7	
10. Chamber Air Temperature		N/A	45.4	

### Note(\*):

1. "Tc" indicates the component's case maximum temperature value specified in its datasheet.
2. "Tm" indicates the measured Tc value under working environmental temperature within product specification.

### 3. Judgment Criteria:

- **Fail** :  $T_m > T_c$ ; The measured value is over specification.
- **Margin Pass** :  $T_c > T_m > T_c - 5^\circ\text{C}$ ; The measured value is within specification with margin.  
It is strongly recommended to add thermal dissipation design for better reliability.
- **Pass** :  $T_m < T_c - 5^\circ\text{C}$ ; The measured value is with safety margin.

### 4. Defect NO. [I121018LABD02](#)

## Sample Configuration & Quantity Under Test:

Quantity: 1 (DSS-CV21)

## Test Result:

No issues were found during the temperature rise operation test.

# Temperature cycle test

**Test Date:** 11-09~ 12-2012

**Test Product:** DSS-CV21

**Test Site:** AAEON QE Dept.

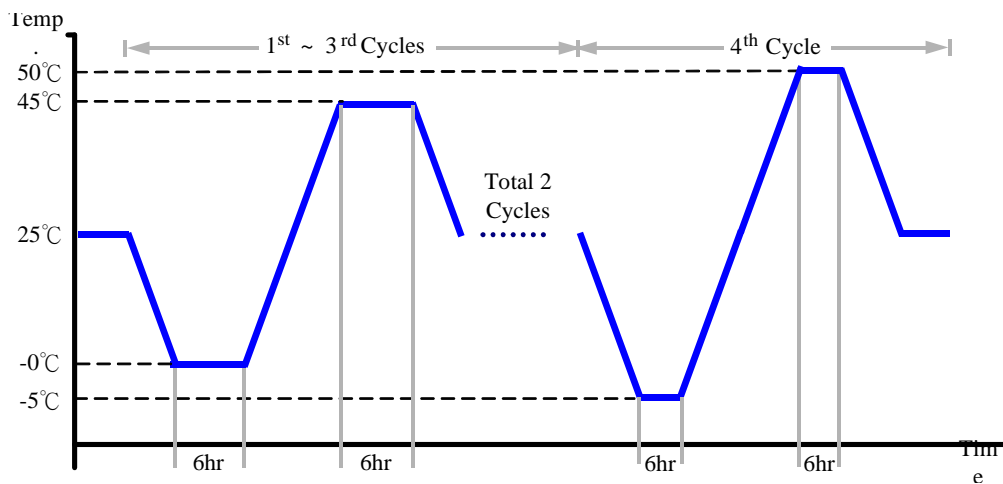
**Test Standard:** Refer to IEC68-2-14 Testing procedures  
Test N: Change of temperature Test

**Test Equipment:**

Programmable Temperature & Humidity Chamber  
K.SON. INS. TECH. CORP.  
Model: THS-D75-100+LN2  
Date of Calibration: 10/13/11  
Serial Number: 6487KT

**Test Condition:**

1. Test Low Temperature: -0°C (1~3 cycles)  
-5°C (4<sup>th</sup> cycle)
2. Test High Temperature: 45°C (1~3 cycles)  
50°C (4<sup>th</sup> cycle)
3. Test dwell time: 6Hrs
4. Temperature slope: 2°C/min
5. Test cycle: 4 cycles
6. Test Environment Curve:



**Sample Configuration & Quantity Under Test:**

Quantity: 1 (DSS-CV21)

**Test Result:**

No issues were found during the temperature operation cycle test.



# High temperature storage test

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**Test Date:** 11-08 ~ 09-2012

**Test Product:** DSS-CV21

**Test Site:** AAEON QE Dept.

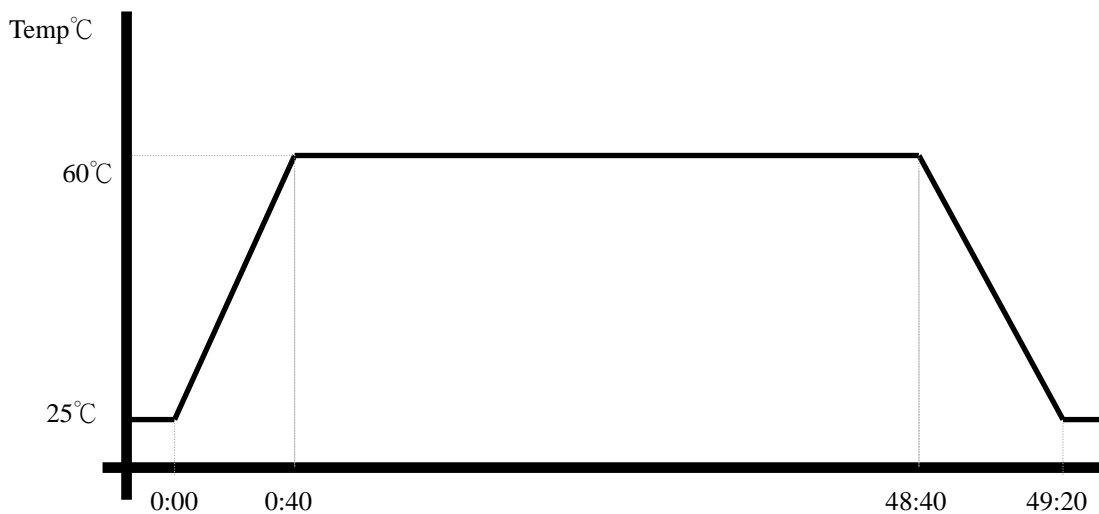
**Test Standard:** Refer to IEC 68-2-2 Testing procedures  
Test Bb: Dry Heat Test (Non-operation)

**Test Equipment:**

Programmable Temperature & Humidity Chamber  
K.SON. INS. TECH. CORP.  
Model: THS-D75-100+LN2  
Date of Calibration: 10/13/11  
Serial Number: 6487KT

**Testing Item:**

1. Test Temperature: 60°C
2. Test Times: 48Hrs
3. Test Software: Windows 7 / Run PassMark Burn In Test 7.0 Pro
4. Test Environment Curve:



**Sample Configuration & Quantity Under Test:**

Quantity: 1 (DSS-CV21)

**Test Result:**

No issues were found after the high temperature storage test.

# Low temperature storage test

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**Test Date:** 11-07 ~ 08-2012

**Test Product:** DSS-CV21

**Test Site:** AAEON QE Dept.

**Test Standard:** Refer to IEC 68-2-1 Testing procedures  
Test Ab: Cold Test (Non-operation)

**Test Equipment:**

Programmable Temperature & Humidity Chamber  
K.SON. INS. TECH. CORP.

Model: THS-D75-100+LN2

Date of Calibration: 10/13/11

Serial Number: 6487KT

**Testing Item:**

1. Test Temperature: -20°C
2. Test Times: 48Hrs
3. Test Software: Windows 7 / Run PassMark Burn In Test 7.0 Pro
4. Test Environment Curve:



**Sample Configuration & Quantity Under Test:**

Quantity: 1 (DSS-CV21)

**Test Result:**

No issues were found after the low temperature storage test.

# Humidity test

**Test Date:** 11-12 ~ 13-2012

**Test Product:** DSS-CV21

**Test Site:** AAEON QE Dept.

**Test Standard:** Refer to IEC 68-2-3 Testing procedures  
Test Ca: Damp heat, steady state (Non-operation)

**Test Equipment:**

Programmable Temperature & Humidity Chamber

K.SON. INS. TECH. CORP.

Model: THS-D75-100+LN2

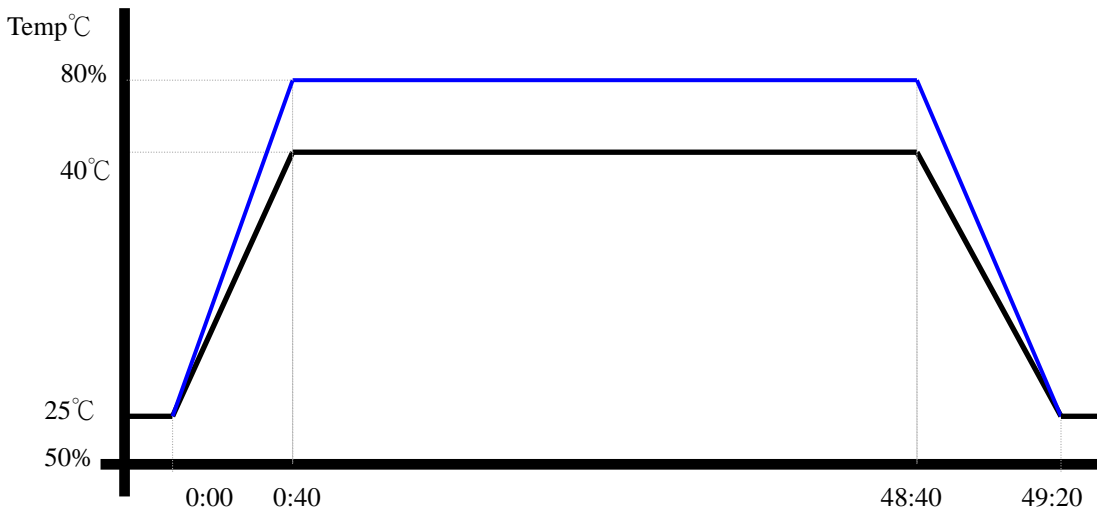
Date of Calibration: 10/13/11

Serial Number: 6487KT

**Testing Item:**

1. Test Temperature: 40°C
2. Test Humidity: 80%RH
3. Test Times: 48Hrs
4. Test Software: Windows 7 / Run PassMark Burn In Test 7.0 Pro
5. Test Environment Curve:

**Humidity %**



**Sample Configuration & Quantity Under Test:**

Quantity: 1 (DSS-CV21)

**Test Result:**

No issues were found after the humidity storage test.

# Cold start and hot start test

**Test Date:** 11-12 ~13-2012

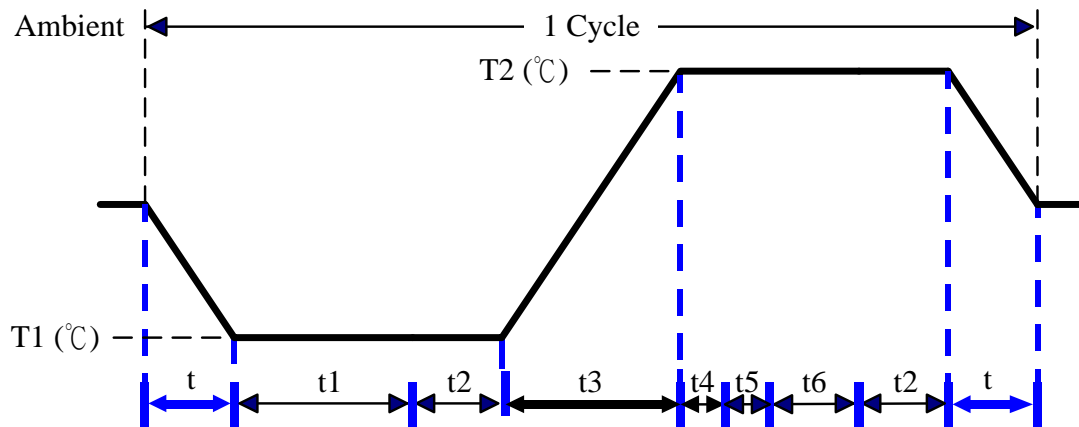
**Test Product:** DSS-CV21

**Test Site:** AAEON QE Dept.

**Test Standard:** Refer to IEC 68-2-14 Testing procedures  
Test N: Change of temperature Test

**Test Equipment:**  
 Programmable Temperature & Humidity Chamber  
 K.SON. INS. TECH. CORP.  
 Model: THS-D75-100+LN2  
 Date of Calibration: 10/13/11  
 Serial Number: 6487KT

**Test Condition:**



Parameters	Description
T1	-5°C
T2	50°C
t1	4 hrs
t2, t6	2 hrs
t4, t5	1hrs
t, t3	2°C/min
n (Cycle)	1

t = temperature slope  
 t, t1, t6: Power Off  
 t2: Power on/off test 10 times (on 2 min / off 5min)  
 t3, t4: Run Burn In Test 7.0 Pro  
 t5: Win 7 Software restart test 3 times  
 Test Software: Windows 7

**Test Result:**

- a. No issues were found during the cold start test.
- b. No issues were found during the hot start test.